

CMOS Digital Integrated Circuits Silicon Monolithic

# 74HCT4051D,74HCT4052D

#### 1. Functional Description

74HCT4051D:8-Channel Analog Multiplexer/Demultiplexer 74HCT4052D:Dual 4-Channel Analog Multiplexer/Demultiplexer

#### 2. General

The 74HCT4051D/74HCT4052D are high speed CMOS ANALOG MULTIPLEXER/DEMULTIPLEXER fabricated with silicon gate C $^2$ MOS technology. They achieve the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

This device may be used as a level converter for interfacing TTL or NMOS to High Speed CMOS. This inputs are compatible with TTL, NMOS and CMOS output voltage levels.

The 74HCT4051D has an 8 channel configuration and the 74HCT4052D has a 4 channel  $\times$  2 configuration.

The digital signal to the control terminal turns "ON" the corresponding switch of each channel a large amplitude signal ( $V_{CC}$  -  $V_{EE}$ ) can then be switched by the small logical amplitude ( $V_{CC}$  - GND) control signal.

For example, in the case of  $V_{\rm CC}$  = 5 V, GND = 0 V,  $V_{\rm EE}$  = -5 V, signals between -5 V and +5 V can be switched from the logical circuit with a single power supply of 5 V. As the ON-resistance of each switch is low, they can be connected to circuits with low input impedance.

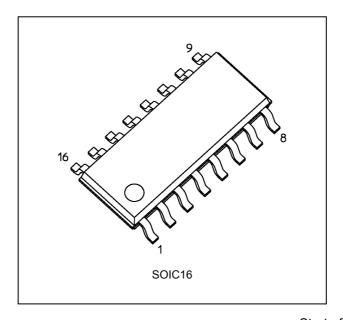
All inputs are equipped with protection circuits against static discharge or transient excess voltage.

#### 3. Features

- (1) Wide operating temperature range:  $T_{\rm opr}$  = -40 to 125 °C (Note 1)
- (2) Low power dissipation:  $I_{CC} = 4.0 \mu A \text{ (max)} \text{ (V}_{CC} = 5.5 \text{ V}, V_{EE} = \text{GND}, T_a = 25 \text{ °C)}$
- (3) Compatible with TTL output:  $V_{IH} = 2.0 \text{ V (min)}$ ,  $V_{IL} = 0.8 \text{ V (max)}$
- (4) Wide interfacing ability: LSTTL, NMOS, CMOS
- (5) Low ON-resistance:  $R_{ON} = 50 \Omega$  (typ.) at  $V_{CC} V_{EE} = 9 V$
- (6) High degree of linearity: THD = 0.020 % (typ.) at  $V_{CC} V_{EE} = 9 V$

Note 1: Operating Range spec of  $T_{opr}$  = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.

#### 4. Packaging



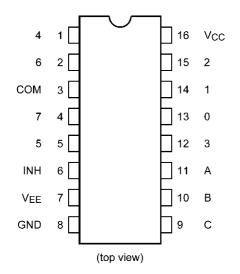
Start of commercial production

2020-07

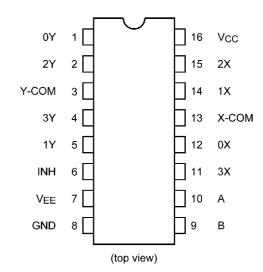


#### 5. Pin Assignment



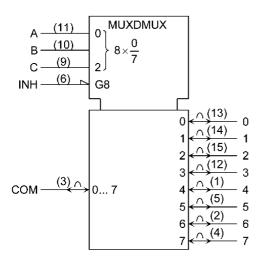


#### 74HCT4052D

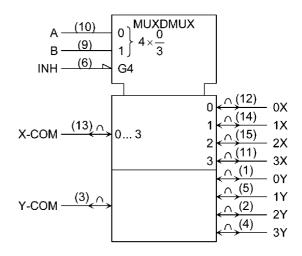


#### 6. IEC Logic Symbol

74HCT4051D

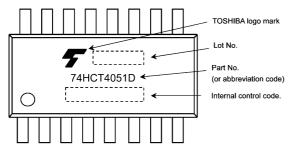


#### 74HCT4052D

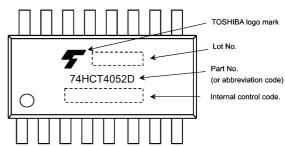


#### 7. Marking





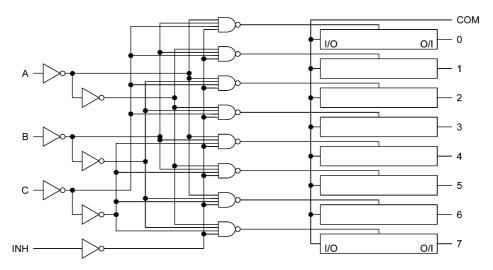
#### 74HCT4052D



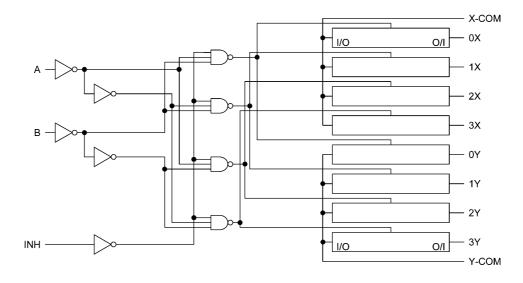


## 8. System Diagram

74HCT4051D



#### 74HCT4052D





#### 9. Truth Table

Input Inhibit	Input C*	Input B	Input A	ON Channel 74HCT4051D	ON Channel 74HCT4052D
L	L	L	L	0	0X, 0Y
L	L	L	Н	1	1X, 1Y
L	L	Н	L	2	2X, 2Y
L	L	Н	Н	3	3X, 3Y
L	Н	L	L	4	_
L	Н	L	Н	5	_
L	Н	Н	L	6	_
L	Н	Н	Н	7	_
Н	Х	Х	Х	None	None

X: Don't care

\*: Except 74HCT4052D

#### 10. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V <sub>CC</sub>		-0.5 to 7.0	V
Supply voltage	V <sub>EE</sub>		-7.0 to 0	V
Supply voltage	V <sub>CC</sub> -V <sub>EE</sub>		-0.5 to 13.0	V
Input voltage	V <sub>IN</sub>		-0.5 to V <sub>CC</sub> + 0.5	V
Switch I/O voltage	V <sub>I/O</sub>		V <sub>EE</sub> - 0.5 to V <sub>CC</sub> + 0.5	V
Input diode current	I <sub>IK</sub>		±20	mA
I/O diode current	I <sub>I/OK</sub>		±20	mA
Switch through current	I <sub>T</sub>		±25	mA
V <sub>CC</sub> /ground current	I <sub>CC</sub>		±50	mA
Power dissipation	P <sub>D</sub>	(Note 1)	500	mW
Storage temperature	T <sub>stg</sub>		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: P<sub>D</sub> derates linearly with -8 mW/°C above 85 °C.

#### 11. Operating Ranges (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V <sub>CC</sub>		4.5 to 5.5	V
Supply voltage	$V_{EE}$		-6.0 to 0	V
Supply voltage	$V_{CC}$ - $V_{EE}$		4.5 to 11.0	V
Input voltage	V <sub>IN</sub>		0 to V <sub>CC</sub>	V
Switch I/O voltage	V <sub>I/O</sub>		V <sub>EE</sub> to V <sub>CC</sub>	V
Operating temperature	T <sub>opr</sub>	(Note 1)	-40 to 125	°C
Input rise and fall times	$t_r, t_f$		0 to 50	μS

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either V<sub>CC</sub> or GND.

Note 1: Operating Range spec of  $T_{opr}$  = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.



#### 12. Electrical Characteristics

# 12.1. DC Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Тур.	Max	Unit
High-level input voltage	V <sub>IH</sub>	_		4.5 to 5.5	2.0	_	_	V
Low-level input voltage	V <sub>IL</sub>	_		4.5 to 5.5		_	0.8	V
ON-resistance	R <sub>ON</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	180	240	Ω
		$V_{I/O} = V_{CC}$ to $V_{EE}$	-4.5	4.5	_	140	190	
		$I_{I/O} \le 2 \text{ mA}$ $V_{IN} = V_{IH} \text{ or } V_{IL}$	-5.5	5.5	_	135	180	
			GND	4.5	_	150	200	
		$V_{I/O} = V_{EE}$	-4.5	4.5	_	135	170	
		$I_{I/O} \le 2 \text{ mA}$	-5.5	5.5		125	170	
		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{I/O} = V_{CC}$ $V_{I/O} < 2 \text{ mA}$	GND	4.5		95	130	
			-4.5	4.5		75	100	
		$I_{I/O} \le 2 \text{ mA}$	-5.5	5.5	_	70	100	
Difference of ON-resistance	$\Delta R_{ON}$	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	10	30	Ω
between switches		$V_{I/O}$ = $V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5		5	12	
			-5.5	5.5		5	11	
Input/Output leakage current	I <sub>OFF</sub>	$V_{OS} = V_{CC}$ or GND	GND	5.5		_	±0.06	μА
(Switch OFF)		$V_{IS}$ = GND or $V_{CC}$ $V_{IN}$ = $V_{IH}$ or $V_{IL}$	-5.5	5.5	_	_	±0.1	
Input/Output leakage current	I <sub>I/O</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND	GND	5.5	_	_	±0.06	μА
(Switch ON)		$V_{IN} = V_{IH}$ or $V_{IL}$	-5.5	5.5	_	_	±0.1	
Control input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	5.5		_	±0.1	μΑ
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	5.5	-	_	4.0	μА
			-5.5	5.5	-	_	8.0	
		Per input: $V_{IN}$ = 0.5 V or 2.4 V Other input: $V_{CC}$ or GND	GND	5.5	_	_	2.0	mA



# 12.2. DC Characteristics (Unless otherwise specified, $T_a$ = -40 to 85 °C)

Characteristics	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Max	Unit
High-level input voltage	V <sub>IH</sub>	_		4.5 to 5.5	2.0	_	V
Low-level input voltage	V <sub>IL</sub>	_		4.5 to 5.5	_	0.8	V
ON-resistance	R <sub>ON</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	300	Ω
		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	_	240	]
		11/0 ≥ 2 111/4	-5.5	5.5	_	225	
		V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	250	]
		$V_{I/O} = V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	_	215	]
		11/0 ≥ 2 111A	-5.5	5.5	_	215	
		V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	165	]
		$V_{I/O} = V_{CC}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	_	125	
		/0 ≥ 2      A	-5.5	5.5	_	125	
Difference of ON-resistance	$\Delta R_{ON}$	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	35	Ω
between switches		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	_	15	
			-5.5	5.5	_	14	
Input/Output leakage current (Switch OFF)	I <sub>OFF</sub>	$V_{OS} = V_{CC}$ or GND $V_{IS} = GND$ or $V_{CC}$	GND	5.5	_	±0.6	μА
(Switch Of 1)		$V_{IN} = V_{IH}$ or $V_{IL}$	-5.5	5.5	_	±1.0	
Input/Output leakage current	I <sub>I/O</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND	GND	5.5	_	±0.6	μА
(Switch ON)		$V_{IN} = V_{IH} \text{ or } V_{IL}$	-5.5	5.5	_	±1.0	]
Control input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	5.5	_	±1.0	μА
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	5.5	_	40.0	μА
			-5.5	5.5	_	80.0	
		Per input: $V_{IN} = 0.5 \text{ V or } 2.4 \text{ V}$ Other input: $V_{CC}$ or GND	GND	5.5	_	2.9	mA



# 12.3. DC Characteristics (Note) (Unless otherwise specified, $T_a$ = -40 to 125 °C)

Characteristics	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Max	Unit
High-level input voltage	V <sub>IH</sub>	_		4.5 to 5.5	2.0	_	V
Low-level input voltage	V <sub>IL</sub>	_		4.5 to 5.5	_	0.8	V
ON-resistance	R <sub>ON</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	340	Ω
		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	_	275	
		11/0 = 2 111A	-5.5	5.5	_	255	
		V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	285	]
		V <sub>I/O</sub> = V <sub>EE</sub>	-4.5	4.5	_	245	]
		$I_{I/O} \le 2 \text{ mA}$	-5.5	5.5	_	245	
		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{I/O} = V_{CC}$ $I_{I/O} \le 2 \text{ mA}$	GND	4.5	_	190	]
			-4.5	4.5	_	145	
			-5.5	5.5	_	145	
Difference of ON-resistance	$\Delta R_{ON}$	$V_{I/O} = V_{CC}$ to $V_{EE}$	GND	4.5	_	35	Ω
between switches			-4.5	4.5	_	15	
		$I_{I/O} \le 2 \text{ mA}$	-5.5 5.5		_	14	
Input/Output leakage current (Switch OFF)	I <sub>OFF</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND V <sub>IS</sub> = GND or V <sub>CC</sub>	GND	5.5	_	±3.0	μА
(SWILCH OFF)		$V_{IN} = V_{IH} \text{ or } V_{IL}$	-5.5	5.5		±5.0	
Input/Output leakage current	I <sub>I/O</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND	GND	5.5		±3.0	μА
(Switch ON)		$V_{IN} = V_{IH}$ or $V_{IL}$	-5.5	5.5	_	±5.0	]
Control input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	5.5	_	±1.0	μА
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	5.5	_	80.0	μА
			-5.5	5.5	_	160.0	
		Per input: V <sub>IN</sub> = 0.5 V or 2.4 V Other input: V <sub>CC</sub> or GND	GND	5.5	_	2.9	mA

Note: Operating Range spec of  $T_{opr}$  = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.



# 12.4. AC Characteristics (Unless otherwise specified, $C_L$ = 50 pF, $T_a$ = 25 °C, Input: $t_r$ = $t_f$ = 6 ns)

Characteristics	Part Number	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Тур.	Max	Unit
Phase difference		ΦΙ/Ο	_	GND	4.5	_	7	12	ns
between input to output				GND	5.5	_	6	10	
				-4.5	4.5	_	5	_	
Output enable time	74HCT4051D	$t_{PZL},t_{PZH}$	$R_L = 1 k\Omega$	GND	4.5	_	30	45	ns
			Figure 1	GND	5.5	_	26	35	
				-4.5	4.5	_	25	35	
	74HCT4052D		$R_L = 1 k\Omega$	GND	4.5	_	30	45	ns
			Figure 1	GND	5.5	_	26	35	
					4.5	_	25	35	
Output disable time	74HCT4051D	$t_{PLZ},t_{PHZ}$	$R_L = 1 k\Omega$	GND	4.5	_	22	30	ns
			Figure 1	GND	5.5	_	21	28	
			-4.5	4.5	_	21	28		
	74HCT4052D		$R_L = 1 k\Omega$	GND	4.5	_	22	30	ns
			Figure 1	GND	5.5	_	21	28	
				-4.5	4.5	_	21	28	
Control input capacitance		C <sub>IN</sub>	_	_		_	5	10	pF
Common terminal	74HCT4051D	C <sub>IS</sub>	Figure 2	-5.0	5.0	_	36	70	pF
capacitance	74HCT4052D					_	19	40	
Switch terminal	74HCT4051D	Cos	Figure 2	-5.0	5.0	_	7	15	pF
capacitance	74HCT4052D					_	7	15	
Feedthrough	74HCT4051D	C <sub>IOS</sub>	Figure 2	-5.0	5.0	_	0.75	2	pF
capacitance	74HCT4052D					_	0.75	2	
Power dissipation	74HCT4051D	C <sub>PD</sub>	Figure 2	GND	5.0	_	11	_	pF
capacitance	74HCT4052D		(Note 1)			_	19		

Note 1:  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

 $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}$ 



# 12.5. AC Characteristics (Unless otherwise specified, $C_L$ = 50 pF, $T_a$ = -40 to 85 °C, Input: $t_r$ = $t_f$ = 6 ns)

Characteristics	Part Number	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Max	Unit
Phase difference between		Φι/Ο	_	GND	4.5		15	ns
input to output				GND	5.5		13	
				-4.5	4.5	_	_	
Output enable time	74HCT4051D	$t_{PZL}, t_{PZH}$	$R_L = 1 k\Omega$	GND	4.5	_	55	ns
			Figure 1	GND	5.5		42	
				-4.5	4.5		41	
	74HCT4052D		$R_L = 1 k\Omega$	GND	4.5	_	55	ns
			Figure 1	GND	5.5		42	
				-4.5	4.5	_	41	
Output disable time	74HCT4051D	$t_{PLZ}, t_{PHZ}$	$R_L = 1 k\Omega$	GND	4.5	_	37	ns
			Figure 1	GND	5.5		34	
				-4.5	4.5	_	34	
	74HCT4052D		$R_L = 1 k\Omega$	GND	4.5	_	37	ns
			Figure 1	GND	5.5		34	
				-4.5	4.5	_	34	
Control input capacitance		C <sub>IN</sub>	_	_	_	_	10	pF
Common terminal	74HCT4051D	C <sub>IS</sub>	Figure 2	-5.0	5.0		70	pF
capacitance	74HCT4052D					_	40	
Switch terminal capacitance	74HCT4051D	Cos	Figure 2	-5.0	5.0	_	15	pF
	74HCT4052D					_	15	]
Feedthrough capacitance	74HCT4051D	C <sub>IOS</sub>	Figure 2	-5.0	5.0	_	2	pF
	74HCT4052D						2	



12.6. AC Characteristics (Note) (Unless otherwise specified, CL = 50 pF,  $T_a$  = -40 to 125 °C, Input:  $t_r$  =  $t_f$  = 6 ns)

Characteristics	Part Number	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Max	Unit
Phase difference between		Φι/Ο	_	GND	4.5	_	17	ns
input to output				GND	5.0	_	15	
				-4.5	4.5	_	_	
Output enable time	74HCT4051D	$t_{PZL}, t_{PZH}$	$R_L = 1 k\Omega$	GND	4.5	_	62	ns
			Figure 1	GND	5.0	_	47	
				-4.5	4.5	_	45	
	74HCT4052D		$R_L = 1 k\Omega$	GND	4.5	_	62	ns
			Figure 1	GND	5.0	_	47	
				-4.5	4.5	_	45	
Output disable time	74HCT4051D	$t_{PLZ}, t_{PHZ}$	$R_L = 1 k\Omega$	GND	4.5	_	42	ns
			Figure 1	GND	5.0	_	38	
				-4.5	4.5	_	38	
	74HCT4052D		$R_L = 1 k\Omega$	GND	4.5	_	42	ns
			Figure 1	GND	5.0	_	38	
				-4.5	4.5	_	38	
Control input capacitance		C <sub>IN</sub>	_	_	_	_	10	pF
Common terminal	74HCT4051D	C <sub>IS</sub>	Figure 2	-5.0	5.0	_	70	pF
capacitance	74HCT4052D					_	40	
Switch terminal capacitance	74HCT4051D	Cos	Figure 2	-5.0	5.0	_	15	pF
	74HCT4052D					_	15	
Feedthrough capacitance	74HCT4051D	C <sub>IOS</sub>	Figure 2	-5.0	5.0	_	2	pF
	74HCT4052D					_	2	

Note: Operating Range spec of  $T_{opr}$  = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.



## 12.7. Analog Switch Characteristics (T<sub>a</sub> = 25 °C) (Note)

Characteristics	Part Number	Symbol	Test Condition		V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Тур.	Unit
Sine Wave Distortion		THD	$R_L = 10 \text{ k}\Omega, C_L = 50 \text{ pF}$	$V_{IN} = 8.0 V_{p-p}$	-4.5	4.5	0.020	%
			f <sub>IN</sub> = 1 kHz	$V_{IN} = 11.0 V_{p-p}$	-5.5	5.5	0.019	
Maximum frequency		f <sub>MAX(I/O)</sub>	Adjust f <sub>IN</sub> voltage to obtain	(Note 1)	-4.5	4.5	190	MHz
response	74HCT4051D		0 dBm at V <sub>OS</sub> Increase f <sub>IN</sub> frequency until	(Note 2)			70	
	74HCT4052D		dB meter reads -3 dB $R_L = 50 \Omega$ , $C_L = 10 pF$				110	
				(Note 1)	-5.5	5.5	200	
	74HCT4051D		f <sub>IN</sub> = 1 MHz, sine wave Figure 3	(Note 2)			80	
	74HCT4052D		3				135	
Feed through attenuation (switch OFF)		FTH	V <sub>IN</sub> is centered at (V <sub>CC</sub> /2). Adjust input for 0 dBm.		-4.5	4.5	-50	dB
			$R_L = 600 \Omega$ , $C_L = 50 pF$ , $f_{IN} = 1 MHz$ , sine wave Figure 4		-5.5	5.5	-50	
Crosstalk (control input to signal output)		X <sub>talk</sub>	$R_L = 600 \Omega, C_L = 50 pF,$ $f_{IN} = 1 MHz,$		-4.5	4.5	140	mV
			square wave $(t_r = t_f = 6 \text{ ns})$ Figure 5		-5.5	5.5	180	
Crosstalk (between any switches)		X <sub>talk</sub>	Adjust $V_{IN}$ to obtain 0 dBm at input. $R_{I} = 600 \Omega$ , $C_{I} = 50 pF$ ,		-4.5	4.5	-50	dB
			f <sub>IN</sub> = 1 MHz, sine wave Figure 6		-5.5	5.5	-50	
			$R_L$ = 50 $\Omega$ , $C_L$ = 15 pF, $f_{\text{IN}}$ = 100 KHz, $V_{\text{SWITCH}}$ = 1 $V_{\text{RMS}}$ Figure 6		-4.5	4.5	-90	dB

Note: These characteristics are determined by design of devices.

Note 1: Input COMMON terminal, and measured at SWITCH terminal.

Note 2: Input SWITCH terminal, and measured at COMMON terminal.



#### 13. AC Test Circuit

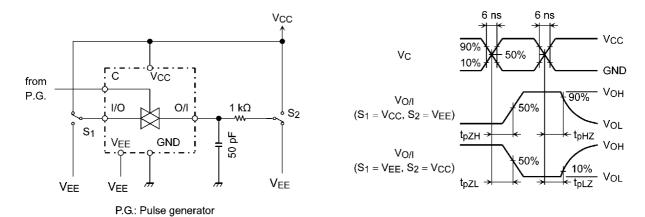


Figure 1 tpLZ, tpHZ, tpZL, tpZH

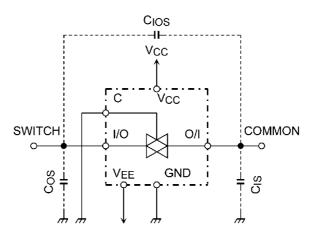


Figure 2 C<sub>IOS</sub>, C<sub>IS</sub>, C<sub>OS</sub>

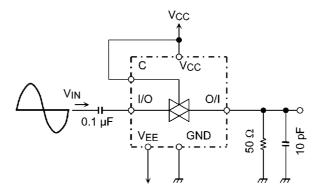


Figure 3 Frequency Response

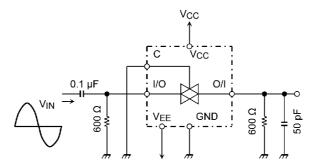
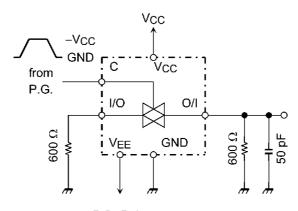


Figure 4 Feedthrough Attenuation





P.G.: Pulse generator

Figure 5 Cross Talk (control input to output signal)

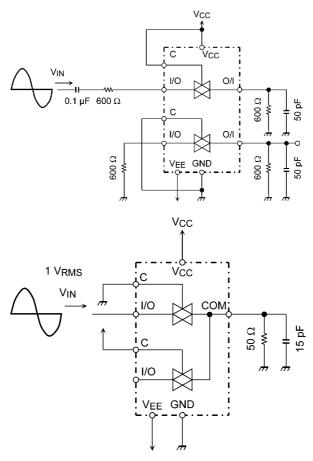


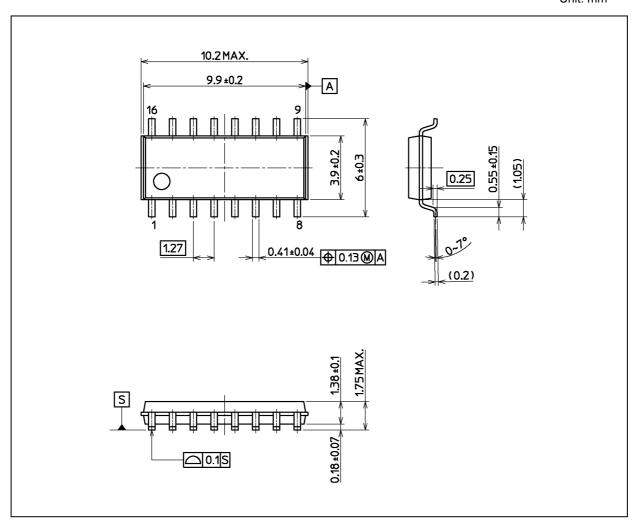
Figure 6 Cross Talk (between any two switches)

Rev.4.0



## **Package Dimensions**

Unit: mm



Weight: 0.15 g (typ.)

	Package Name(s)
Nickname: SOIC16	



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